Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/716,890	HON ET AL.	
Examiner	Art Unit	
Patricia Leith	1654	

SEARCHED				
Class	Subclass	Date	Examiner	
updated	all	4/12/2005	PL	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
424	641,642	4/12/2005	PL	
424	682,642	4/12/2005	PL	

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY)
	DATE	EXMR
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